

GSM3164X5F

30V N-Channel MOSFETs

Product Description

These N-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode.

These devices are well suited for high efficiency fast switching applications.

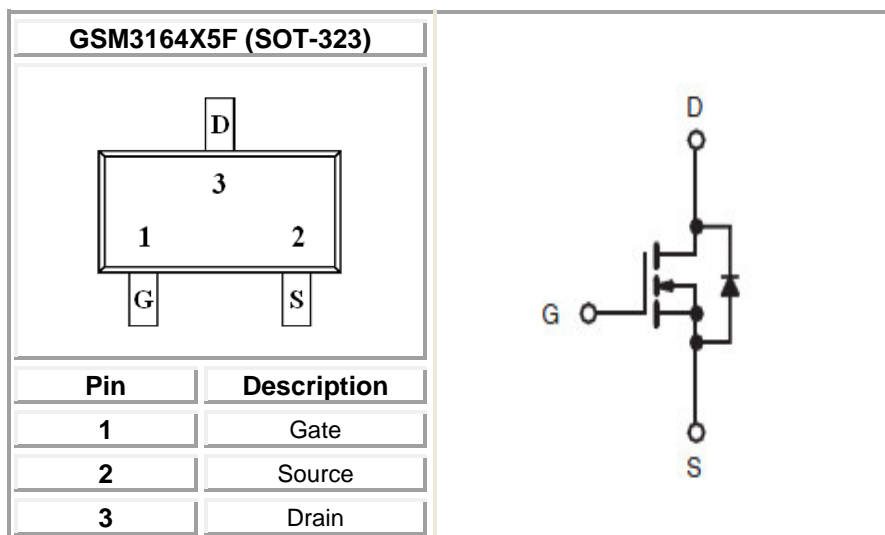
Features

- 30V/3.4A, $R_{DS(ON)}=65m\Omega@V_{GS}=10V$
- 30V/3.0A, $R_{DS(ON)}=75m\Omega@V_{GS}=4.5V$
- 30V/2.0A, $R_{DS(ON)}=90m\Omega@V_{GS}=2.5V$
- Low Gate Threshold Voltage
- Low On-Resistance
- Fast Switching Speed
- SOT-323 package design

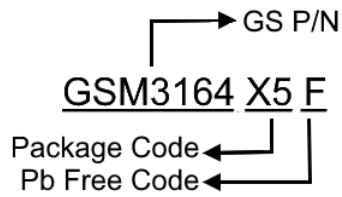
Applications

- Power Management in Notebook
- Battery Powered System
- DC/DC Converter

Packages & Pin Assignments

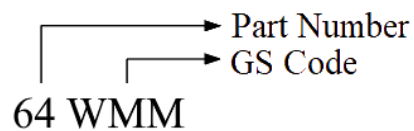


Ordering Information



Part Number	Package	Quantity Reel
GSM3164X5F	SOT-323	3000 PCS

Marking Information



Absolute Maximum Ratings

(T_A=25°C Unless otherwise noted)

Symbol	Parameter	Typical	Unit
V _{DSS}	Drain-Source Voltage	30	V
V _{GSS}	Gate –Source Voltage	±12	V
I _D	Continuous Drain Current	T _A =25°C	3.8
		T _A =70°C	3
I _{DM}	Pulsed Drain Current	16	A
P _D	Power Dissipation	T _A =25°C	1.2
		T _A =70°C	0.8
T _J	Operating Junction Temperature	-55/150	°C
T _{STG}	Storage Temperature Range	-55/150	°C
R _{θJA}	Thermal Resistance-Junction to Ambient	110	°C/W

Electrical Characteristics

(T_A=25°C unless otherwise noted)

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static						
V _{(BR)DSS}	Drain-Source Breakdown Voltage	V _{GS} =0V, I _D =250μA	30			V
V _{GS(th)}	Gate Threshold Voltage	V _{DS} =V _{GS} , I _D =250μA	0.4		1.2	V
I _{GSS}	Gate Leakage Current	V _{DS} =0V, V _{GS} =±12V			±100	nA
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =24V, V _{GS} =0V T _J =25°C			1	μA
		V _{DS} =24V, V _{GS} =0V, T _J =55°C			5	
R _{DS(on)}	Drain-Source On-Resistance (Note 2)	V _{GS} =10V, I _D =3.4A		55	65	mΩ
		V _{GS} =4.5V, I _D =3.0A		65	75	
		V _{GS} =2.5V, I _D =2.0A		80	90	
g _{FS}	Forward Transconductance	V _{DS} =5V, I _D =3.4A		6		S
V _{SD}	Diode Forward Voltage (Note 2)	I _S =1A, V _{GS} =0V			1.2	V
Dynamic						
C _{iss}	Input Capacitance	V _{DS} =15V, V _{GS} =0V, f=1MHz		662		pF
C _{oss}	Output Capacitance			52		
C _{rss}	Reverse Transfer Capacitance			45		
Q _g	Total Gate Charge	V _{DS} =15V, V _{GS} =4.5V, I _D =3.0A		8.4		nC
Q _{gs}	Gate-Source Charge			1.6		
Q _{gd}	Gate-Drain Charge			1.8		
t _{d(on)}	Turn-On Time	V _{DD} =10V, R _G =3.3Ω, I _D =3.0A, V _{GS} =4.5V		3.2		ns
T _r				41.8		
t _{d(off)}	Turn-Off Time			21.2		
T _f				6.4		

Note:

- 1.The data testing by surface mounting on a 1 inch2 / FR4 board/ 2 OZ copper.
- 2.The data testing by pulsed, pulse width ≤ 300us, duty cycle ≤ 2%
- 3.The power dissipation is limited by 150°C junction temperature
- 4.The data is theoretically the same as ID and IDM, in real applications, should be limited by total power dissipation.

Typical Performance Characteristics

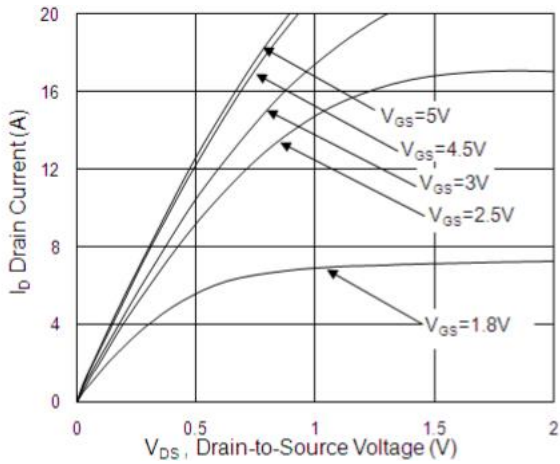


Fig.1 Typical Output Characteristics

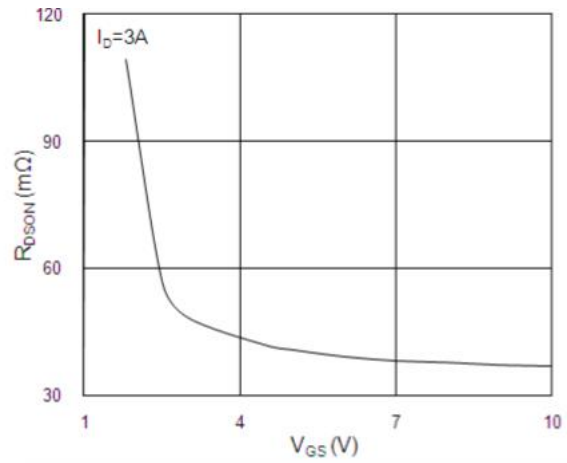


Fig.2 On-Resistance vs. Gate-Source

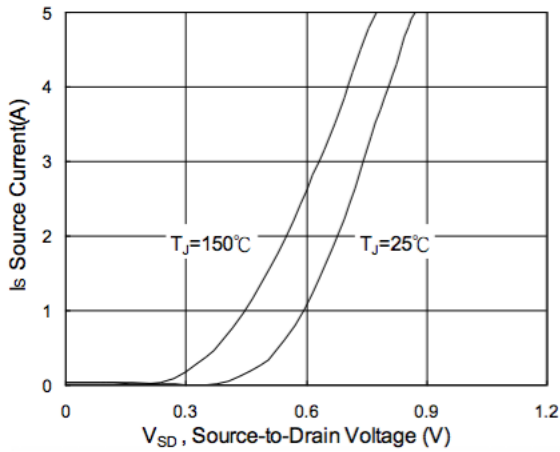


Fig.3 Forward Characteristics of Reverse

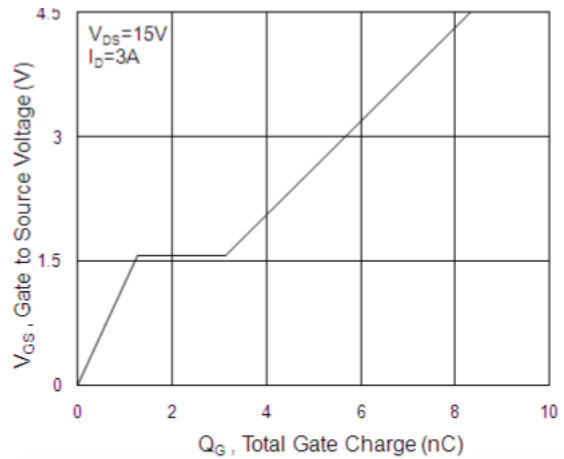


Fig.4 Gate-Charge Characteristics

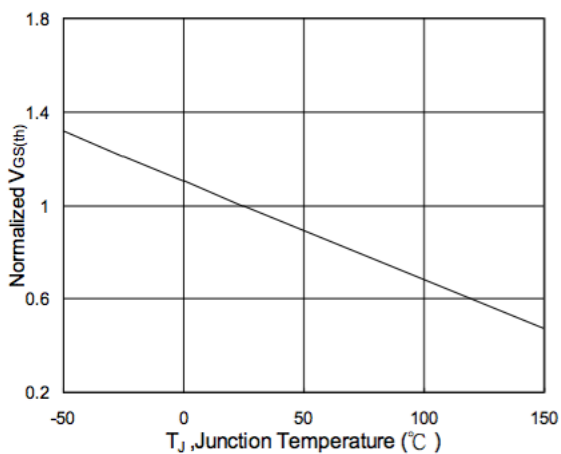


Fig.5 Normalized $V_{GS(th)}$ vs. T_J

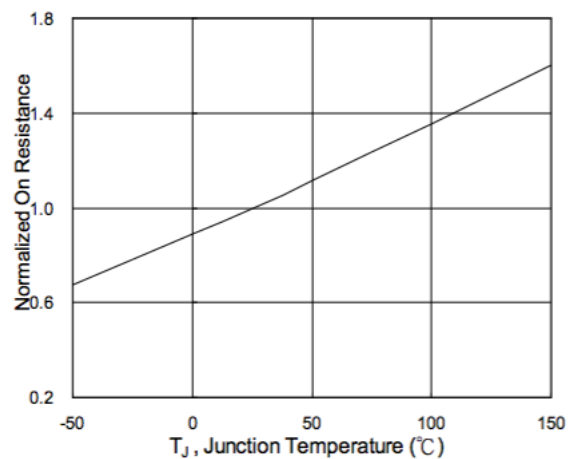


Fig.6 Normalized $R_{DS(on)}$ vs. T_J

Typical Performance Characteristics (N-Channel Continue)

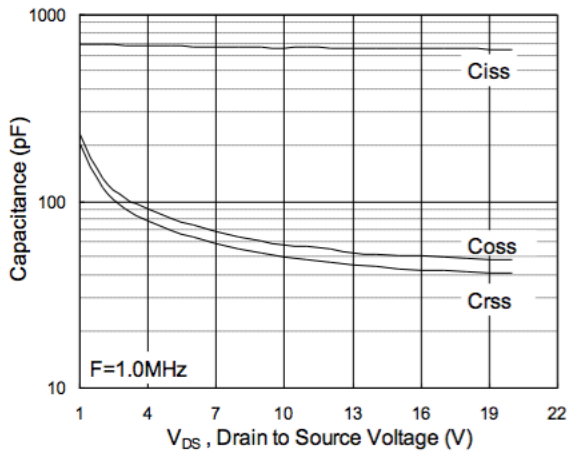


Fig.7 Capacitance

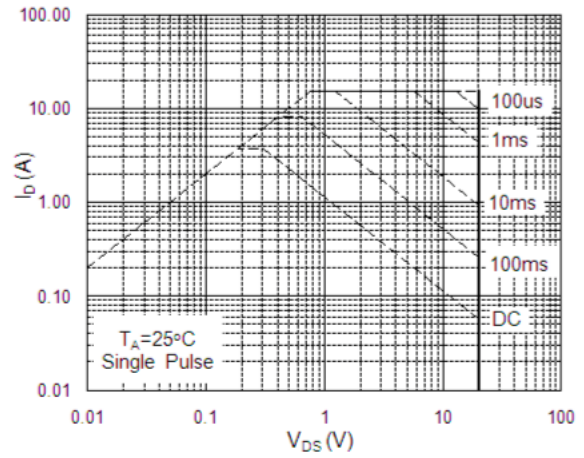


Fig.8 Safe Operating Area

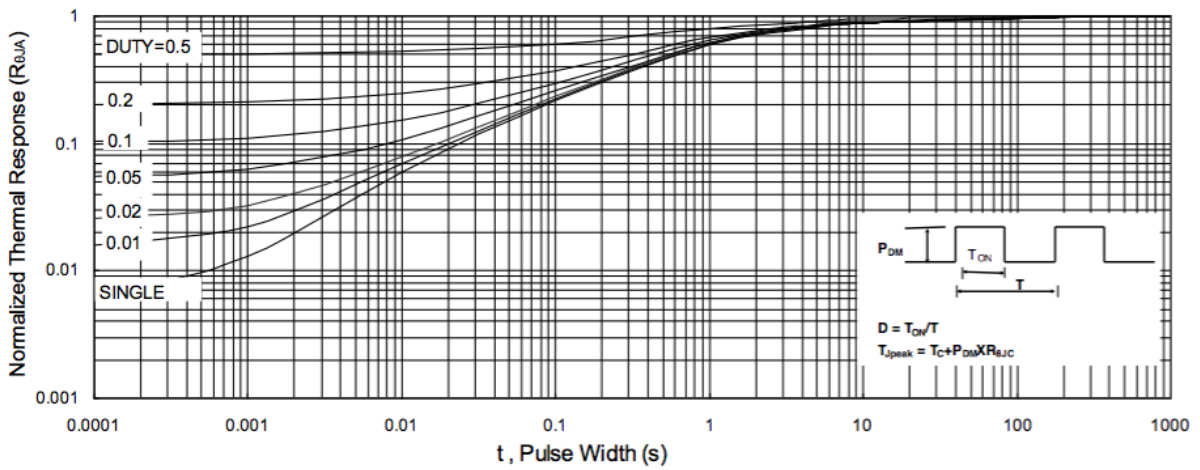
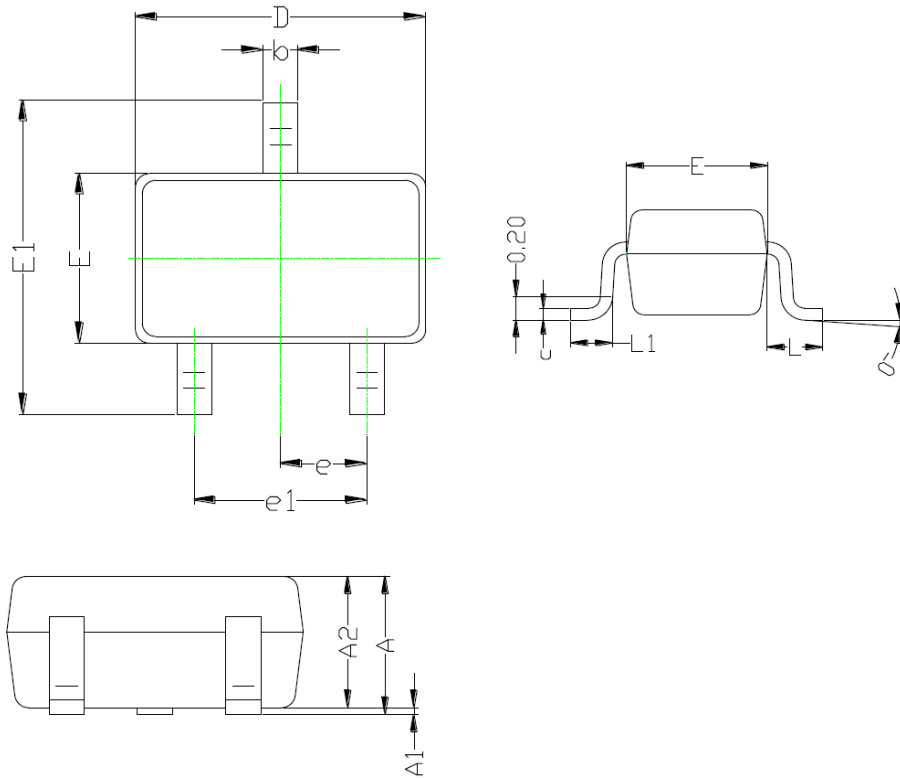


Fig.9 Normalized Maximum Transient Thermal Impedance

Package Dimension

SOT-323









Dimensions				
Symbol	Millimeters		Inches	
	Min	Max	Min	Max
A	0.900	1.000	0.035	0.039
A1	0.000	0.100	0.000	0.004
A2	0.900	1.000	0.035	0.039
b	0.200	0.400	0.008	0.015
c	0.080	0.150	0.003	0.006
D	2.000	2.200	0.079	0.086
E	1.150	1.350	0.059	0.053
E1	2.150	2.400	0.084	0.094
e	0.650 TYP		0.025 TYP	
e1	1.200	1.400	0.047	0.055
L	0.525 REF		0.021 REF	
L1	0.260	0.450	0.010	0.017
θ	0°	8°	0°	8°

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